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+ "selection register", + "test pattern register", + "external term"

SEARCH

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Please review the [Quick Tips](#) below or for more information see the [Search Tips](#).

Quick Tips

- Enter your search terms in lower case with a space between the terms.

sales offices

You can also enter a full question or concept in plain language.

Where are the sales offices?

- Capitalize proper nouns to search for specific people, places, or products.

John Colter, Netscape Navigator

- Enclose a phrase in double quotes to search for that exact phrase.

"museum of natural history" "museum of modern art"

- Narrow your searches by using a **+** if a search term must appear on a page.

museum +art

- Exclude pages by using a **-** if a search term must not appear on a page.

museum -Paris

Combine these techniques to create a specific search query. The better your description of the information you want, the more relevant your results will be.

museum + "natural history" dinosaur -Chicago

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Tue, 12 Dec 2006, 5:30:27 PM EST

Search Query Display

Select a search number (#) to:

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Display

Combine search queries using AND, OR, or NOT

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Run a search

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#1 (selection register<and>test pattern register)<and>external terminal 0

Results

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